

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO. 1344.1133

Sheet 1 of 1

ENT AND TRADEMARK OFFICE | 1344

FIRST NAMED INVENTOR

10/790,356

INFORMATION DISCLOSURE STATEMENT Yuic

(Use several sheets if necessary)

Yuichi KAWAHATA

GROUP ART UNIT

March 2, 2004

2872

U.S. PATENT DOCUMENTS

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	DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
AA	6,392,807	05/21/02	Barbarossa et al.			
AB	2003/ 0081318A1	05/01/03	Shirasaki et al.			
AC						
AD						
AE						
AF						
	AB AC AD AE	AA 6,392,807 AB 2003/ 0081318A1 AC AD AE	AA 6,392,807 05/21/02 AB 2003/ 0081318A1 05/01/03 AC AD AE	NO. DATE NAME AA 6,392,807 05/21/02 Barbarossa et al. AB 2003/ 0081318A1 05/01/03 Shirasaki et al. AC AD AE	DOCUMENT NO. DATE NAME CLASS AA 6,392,807 05/21/02 Barbarossa et al. AB 2003/ 0081318A1 05/01/03 Shirasaki et al. AC AD AE	DOCUMENT DATE NAME CLASS CLASS

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
LL	AG	2001-313607	09/11/01	Japan		only
	AH					
	Al					
-	AJ					

OTHER RE	FEREN	ICES (Including Author, Title, Date, Pertinent Pages, Etc.)	TRANSI YES	ATION NO
LL	AK	M. Shirasaki, et al., "Virtually Imaged Phased Array With Graded Reflectivity," IEEE Photonics Technology Letters, Vol. 11, No. 11, Nov. 1999 (pages 1443-1445)	xx	
LL	AL	EP Search Report for corresponding EP Application EP 04004197.2 dated April 1, 2005	xx	

EXAMINER	DATE CONSIDERED	
/Li Liu/	11/15/2006	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE

PATENT AND TRADEMARK OFFICE FIRST NAMED INVENTOR

ATTORNEY DOCKET NO.

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

1344.1133	TBA
FIRST NAMED INVENTOR	
Yuichi KAWAHATA	
FILING DATE	GROUP ART UNIT
March 2, 2004	TBA

APPLICATION NO.

U.S. PATENT DOCUMENTS

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EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
LL	AA	5,930,045	07/27/99	Shirasaki			
LL	AB	5,999,320	12/07/99	Shirasaki			<u>-</u>
	AC						
	AD			·			
	AE						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANS YES	LATION NO
LL	AG	2000- 511655	09/05/00	Japan (corresponds to USP 5,930,045)			Î	xx
LL	АН	09-043057	02/14/97	Japan (corresponds to USP 5,999,320)				xx
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	AL							

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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EXAMINER		DATE CONSIDERED 11/15/2006	
	/Li Liu/	11/15/2006	
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.